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Testing of

Electromagnetic Emissions

per

USA: CFR Title 47, Part 15.231 (Emissions) USA: CFR Title 47, Part 2.1091;2.1093 (Exposure) Canada: ISED RSS-210/GENe (Emissions) Canada: ISED RSS-102 (Exposure)

are herein reported for

Strattec Security Corporation AM Series

Test Report No.: 20160809-RPTWAC010030Br0 Copyright C 2016

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Report by:	Dr. Joseph Brunett, EMC-002790-NE	Report Date of Issue:	August 9, 2016

Results of testing completed on (or before) August 3, 2016 are as follows.

Emissions: The transmitter intentional emissions **COMPLY** with the regulatory limit(s) by no less than 0.8 dB. Transmit chain spurious or harmonic emissions **COMPLY** by no less than 6.5 dB. Unintentional spurious emissions from digital circuitry **COMPLY** with radiated emission limit(s) by at least 20 dB.

Revision History

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F	Rev. No.	Date	Details	Revised By
r	:0	August 9, 2016	Initial Release.	J. Brunett
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1 Test Specifications, Procedures, Location, and Equipment List

1.1 Test Specification and General Procedures

The ultimate goal of Strattec Security Corporation is to demonstrate that the Equipment Under Test (EUT) complies with the Rules and/or Directives below. Detailed in this report are the results of testing the Strattec Security Corporation AM Series for compliance to:

Country/Region	Rules or Directive	Referenced Section(s)
United States	Code of Federal Regulations	CFR Title 47, Part 15.231
Canada	ISED Canada	ISED RSS-210/GENe

Strattec Security Corporation has determined that the equipment under test is subject to the rules and directives above at the date of this testing. In conjunction with these rules and directives, the following specifications and procedures are followed herein to demonstrate compliance (in whole or in part) with these regulations.

ANSI C63.4:2014	"Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz" $$
ANSI C63.10:2013 (USA)	"American National Standard of Procedures for Compliance Testing of Unli- censed Wireless Devices"
CFR 47 2.1091/1093	"447498 D01 General RF Exposure Guidance v06: RF Exposure Procedures and Equipment Authorization Policies for Mobile and Portable Devices"
ISED Canada	"The Measurement of Occupied Bandwidth"
ICES-003; Issue 6 (2016)	"Information Technology Equipment (ITE) Limits and methods of measurement"

1.2 Test Location

The EUT was fully tested by **Willow Run Test Labs, LLC**, 8501 Beck Road, Building 2227, Belleville, Michigan 48111 USA. Test Facility description and attenuation characteristics are on file with the FCC Laboratory, Columbia, Maryland (FCC Reg. No: 688478) and with ISED Canada, Ottawa, ON (File Ref. No: IC 8719A-1). Table 1 lists all site(s) employed herein. Specific test sites utilized are also listed in the test results sections of this report.

Table 1: Test Site List.

Description	Location	Quality Num.
OATS (3 meter)	8501 Beck Rd. Bldg 2227, Belleville MI 48111	OATSA

1.3 Equipment Used

Pertinent test equipment used for measurements at this facility is listed in Table 2. The quality system employed at Willow Run Test Labs, LLC has been established to ensure all equipment has a clearly identifiable classification, calibration expiry date, and that all calibrations are traceable to the SI through NIST, other recognized national laboratories, accepted fundamental or natural physical constants, ratio type of calibration, or by comparison to consensus standards.

Table 2: Equipment List.

Description	Manufacturer/Model	\mathbf{SN}	Quality Num.	Last Cal By / Date Due
Spectrum Analyzer	Rhode-Schwarz / FSV30	101660	RSFSV30001	RS / May-2018
Dipole Set (20-1000 MHz)	EMCO / 3121C	9504-1121	DIPEMC001	Lib. Labs / Sep-2016
Quad Ridge Horn	ETS Lind. / 3164-04	00066988	HRNQR316401	Lib. Labs / April-2017

2 Configuration and Identification of the Equipment Under Test

2.1 Description and Declarations

The equipment under test is an automotive Remote Keyless Entry transmitter. The EUT is approximately $9 \ge 3 \ge 1.5$ cm (approx.) in dimension, and is depicted in Figure 1. It is powered by a 3 VDC Lithium cell battery. In use, this device is hand held. Table 3 outlines provider declared EUT specifications.



Figure 1: Photos of EUT.

Table 3: EUT Declarations.

General Declarations			
Equipment Type:	RKE Transmitter	Country of Origin:	Not Declared
Nominal Supply:	3 VDC	Oper. Temp Range:	-20° C to $+65^{\circ}$ C
Frequency Range:	314.9 MHz	Antenna Dimension:	Not Declared
Antenna Type:	integral	Antenna Gain:	Not Declared
Number of Channels:	1	Channel Spacing:	Not Applicable
Alignment Range:	Not Declared	Type of Modulation:	FSK
United States			
FCC ID Number:	OHT3731465	Classification:	DSC
Canada			
IC Number:	5461A-3731465	Classification:	Remote Control Device, Ve-
IC Number:	J401A-3731403	Classification:	hicular Device

2.1.1 EUT Configuration

The EUT is configured for testing as depicted in Figure 2.

EUT STRATTEC FCC ID: OHT3731465 IC: 5461A-3731465

Figure 2: EUT Test Configuration Diagram.

2.1.2 Modes of Operation

There is only a single mode of operation. When manually activated by button press the EUT transmits a finite set of transmitted frames.

2.1.3 Variants

There is only a single electrical variant of the EUT. The PCB employed is placed into two unique housings. See labeling exhibit for details.

2.1.4 Test Samples

Four samples in total were provided, including two normal operating PCBs and two PCB programmed for CW transmission (one of each in an all plastic housing and the other in a metal+plastic hybrid housing).

2.1.5 Functional Exerciser

Normal operating EUT functionality was verified by observation of transmitted signal.

2.1.6 Modifications Made

There were no modifications made to the EUT by this laboratory.

2.1.7 Production Intent

The EUT appears to be a production ready sample.

2.1.8 Declared Exemptions and Additional Product Notes

None.

3 Emissions

3.1 General Test Procedures

3.1.1 Radiated Test Setup and Procedures

Radiated electromagnetic emissions from the EUT are first pre-scanned in our shielded anechoic chamber or GTEM test cell. Spectrum and modulation characteristics of all emissions are recorded. Instrumentation, including spectrum analyzers and other test equipment as detailed in Section 1.2 are employed. After pre-scan, emission measurements are made on the test site of record. If the EUT connects to auxiliary equipment and is table or floor standing, the configurations prescribed in relevant test standards are followed. Alternatively, a layout closest to normal use (as declared by the provider) is employed if the resulting emissions appear to be worst-case in such a configuration. See Figure 3. All intentionally radiating elements that are not fixed-mounted in use are placed on the test table lying flat, on their side, and on their end (3-axes) and the resulting worst case emissions are recorded. If the EUT is fixed-mounted in use, measurements are made with the device oriented in the manner consistent with installation and then emissions are recorded.

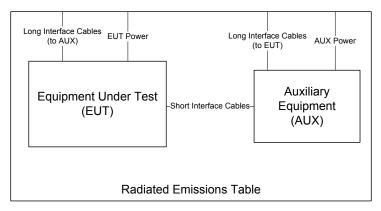


Figure 3: Radiated Emissions Diagram of the EUT.

If the EUT exhibits spurious emissions due to internal receiver circuitry, such emissions are measured with an appropriate carrier signal applied. For devices with intentional emissions below 30 MHz, a shielded loop antenna is used. It is placed at a 1 meter receive height. Emissions between 30 MHz and 1 GHz are measured using tuned dipoles and/or calibrated broadband antennas. For both horizontal and vertical polarizations, the test antenna is raised and lowered from 1 to 4 m in height until a maximum emission level is detected. The EUT is then rotated through 360° in azimuth until the highest emission is detected. The test antenna is then raised and lowered one last time from 1 to 4 m and the worst case value is recorded. Emissions above 1 GHz are characterized using standard gain horn or broadband ridge-horn antennas on our OATS with a 4×5 m rectangle of H-4 absorber placed over the ground screen covering the OATS ground screen. Care is taken to ensure that test receiver resolution and video bandwidths meet the regulatory requirements, and that the emission bandwidth of the EUT is not reduced. Photographs of the test setup employed are depicted in Figure 4.

Where regulations allow for direct measurement of field strength, power values (dBm) measured on the test receiver / analyzer are converted to $dB\mu V/m$ at the regulatory distance, using

$$E_{dist} = 107 + P_R + K_A - K_G + K_E - C_F$$

where P_R is the power recorded on spectrum analyzer, in dBm, K_A is the test antenna factor in dB/m, K_G is the combined pre-amplifier gain and cable loss in dB, K_E is duty correction factor (when applicable) in dB, and C_F is a distance conversion (employed only if limits are specified at alternate distance) in dB. This field strength value is then compared with the regulatory limit. If effective isotropic radiated power (EIRP) is computed, it is computed as

$$EIRP(dBm) = E_{3m}(dB\mu V/m) - 95.2.$$

When presenting data at each frequency, the highest measured emission under all possible EUT orientations (3-axes) is reported.

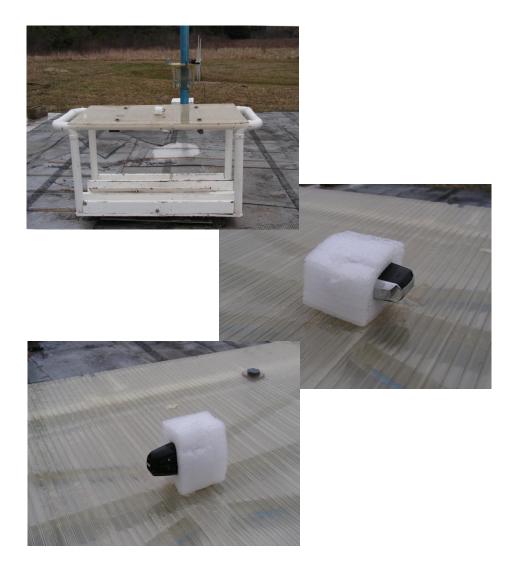


Figure 4: Radiated Emissions Test Setup Photograph(s).

3.1.2 Conducted Emissions Test Setup and Procedures

Battery Power Conducted Spurious The EUT is not subject to measurement of power line conducted emissions as it is powered solely by its internal battery.

3.1.3 Power Supply Variation

Tests at extreme supply voltages are made if required by the the procedures specified in the test standard, and results of this testing are detailed in this report.

In the case the EUT is designed for operation from a battery power source, the extreme test voltages are evaluated over the range specified in the test standard; no less than $\pm 10\%$ of the nominal battery voltage declared by the manufacturer. For all battery operated equipment, worst case intentional and spurious emissions are re-checked employing a new (fully charged) battery.

3.1.4 Thermal Variation

Tests at extreme temperatures are made if required by the procedures specified in the test standard, and results of this testing are detailed in this report. The provider has declared that the EUT is designed for operation over the temperature range -20° C to $+65^{\circ}$ C. Before any temperature measurements are made, the equipment is allowed to reach a thermal balance in the test chamber, temperature and humidity are recorded, and thermal balance is verified via a thermocouple–based probe.

3.2 Intentional Emissions

3.2.1 Fundamental Emission Pulsed Operation

Test Setup & Procedure The test equipment and facilities were setup in accordance with the standards and procedures listed in Section 1.1. Environmental conditions were set at the appropriate temperature and thermal balance was checked with a thermocouple based probe. Duty cycle is reported for all relevant modes of operation. The test equipment employed includes RSFSV30001, DIPEMC001.

Measurement Results The details and results of testing the EUT are summarized in Table 4. Plots showing the measurements made to obtain these values are provided in Figure 5.

Table 4: Fundamental Emission Pulsed Operation.

Detector	Span	IF Bandwidth	Video Bandwidth	Test Date: Test Engineer:	25-Jul-16 Joseph Brunett
Pk	0	1 MHz	3 MHz	EUT: EUT Mode: Meas. Distance:	Strattec AM Series Modulated
				Meas. Distance:	10 cm

		Over	all Trans	mission		Internal Frame Characteristics					
		Min. Repetition		Total Transmission				-	ted Duty Cycle		
#	EUT Test Mode*	Rate (sec)	Frames	Length (sec)	Length (ms)	Period (ms)	Frame Encoding	(%)	(dB)		
1	Worst-Case Manual Button Press	Single	2	0.52	209.0	268.0	When manually actuated button press the EUT transmits no less than two FSK frames Each frame is 209 ms in duration and consists of three FSK packets. Each packet is 68.75 ms with a inter-packet off-time of 1.1 ms.	98.9	-0.1		

Example Calculation: Worst Case Duty (%) =(100 ms - 1.1 ms) / 100 ms = 98.9 % Equipment Used: DIPEMC001, RSFSV30001

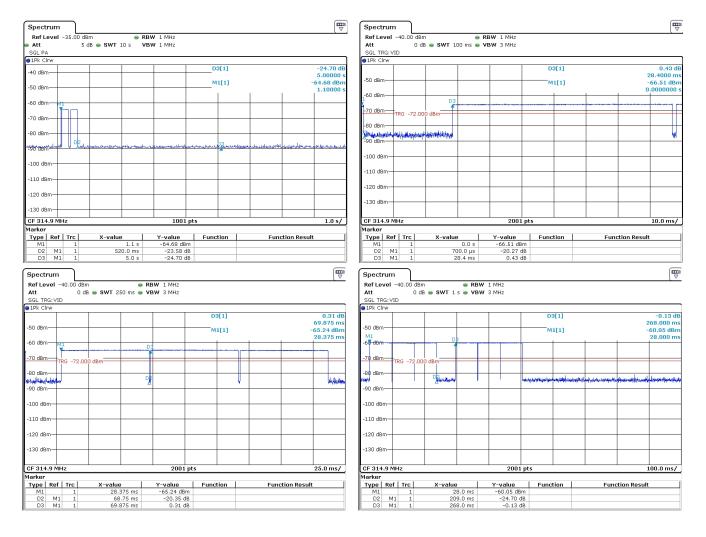


Figure 5: Fundamental Emission Pulsed Operation.

3.2.2 Fundamental Emission Bandwidth

Test Setup & Procedure The test equipment and facilities were setup in accordance with the standards and procedures listed in Section 1.1. Environmental conditions were set at the appropriate temperature and thermal balance was checked with a thermocouple based probe. Emission bandwidth (EBW) of the EUT is measured with the device placed in the test mode(s) with the shortest available frame length and minimum frame spacing. The 20 dB EBW is measured as the max-held peak-detected signal when the IF bandwidth is greater than or equal to 1% of the receiver span. For complex modulations other than ASK and FSK, the 99% emission bandwidth per IC test procedures has a different result, and is also reported. The test equipment employed includes RSFSV30001, DIPEMC001.

Measurement Results The details and results of testing the EUT are summarized in Table 5. Plots showing the measurements made to obtain these values are provided in Figure 6.

Table 5: Fundamental Emission Bandwidth.

					Test Date:	1-Aug-16
	Detector	IF Bandwidth	Video Bandwidth		Test Engineer:	Joseph Brunett
Pk		10 kHz 30 kHz			EUT:	Strattec AM Series
					EUT Mode:	Modulated
					Meas. Distance:	10 cm
						FOOTO
						FCC/IC
		Center Frequency	20 dB EBW	EBW Limit	99% OBW	
#	Modulation	(MHz)	(MHz)	(MHz)	(MHz)	
1	FSK	314.9	0.0660	0.78725	0.08046	
2						

Equipment Used: DIPEMC001, RSFSV30001

Specti	um																			ſ	₩
Ref Le	vel -4	40.00	dBm				RBW	10 kl	Ηz												-
Att			0 dB	SWT	2 r	ns 👄	VBW	30 kl	-lz N	lode	Swe	ер									
●1Pk Vie	ЭW																				
												D3[1	1							-0.49	dB
50 ID																			6	5.970 l	kHz
-50 dBm												Occ	Bw					80.45	977	70115	kHz
co in												M1[1	1						-6	7.01 d	Bm
-60 dBm										М1								314	.90	8500 N	1Hz
-70 dBm									^	X											
-70 aBm									$-\tau$												
-80 dBm										$ \rangle$											
-60 UBII									-	7											
-90 dBm									P.	- ch	52 V										
-90 aBm									7		1										
-100 dB								1	/		2										
-100 UB	and	www			5	n_~~	$\sim \sim$	~			6	m.	\sim		A	~^~			~~~	n 0- a	~~
-110 dB					100		~								1 4 4 6 -		1.20		×.	- 4 K - 4	20
-110 00																					
-120 dB																					
120 00																					
-130 dB																					
100 00																					
CF 314	.9 MH	z							2001	l pts								S	pan	1.0 MI	Ηz
Marker																					
	Ref	Trc		X-value			Y-value			Function		n	Function Result								
M1		1				85 MH		-67.01 dBm													
T1		1		314.858521 MHz			-89.92 dB					Bw					80.45	5977	0115 kl	Ηz	
T2		1		314.938981 MHz			-89.67 dBm														
D2	M1	1			-44.48 kHz		-20.22 dB														
D3	D2	1			65.	97 kH	IZ		-0.49	dB											

Figure 6: Fundamental Emission Bandwidth.

3.2.3 Fundamental Emission Field Strength

Test Setup & Procedure The test equipment and facilities were setup in accordance with the standards and procedures listed in Section 1.1. Environmental conditions were set at the appropriate temperature and thermal balance was checked with a thermocouple based probe. Fundamental emissions are measured at the regulatory distance on our OATS. The test equipment employed includes RSFSV30001, DIPEMC001.

Measurement Results The details and results of testing the EUT are summarized in Table 6.

Table 6: Fundamental Emission Field Strength.

	Frequency Range		y Range Det			IF Bandwidth			lwidth	Test Date:	25-Jul-16		
25	25 MHz f 1 000 MHz			00 MHz Pk/QPk				300 kH	[z	Test Engineer:		Joseph Brunett	
	$f > 1\ 000\ MHz$		Pk		1 MHz			3 MH	z	EUT:	S	trattec AM Series	
	f > 1 000 MHz			Avg	1 MHz			10 kH	Z	EUT Mode:		CW	
										Meas. Distance:		3 meters	
												FCC/IC	
	Freq.	Ant.	Ant.	Pr (Pk)	Pr (Avg)*	Ka	Kg	E3(Pk)	E3(Avg)	FCC/IC E3(Avg)	Pass		
#	MHz	Used	Pol.	dBm	dBm	dB/m	dB	dBµV/n	dBµV/m	Lim. dBµV/m	dB	Comments	
1	Plastic Side	es											
2	314.9	LOGPER	Н	-17.1	-17.2	14.1	29.8	74.2	74.1	75.6	1.5	end	
3	314.9	LOGPER	V	-19.4	-19.5	14.1	29.8	71.9	71.8	75.6	3.8	side	
4	Chrome Si	des											
5	314.9	LOGPER	Н	-16.4	-16.5	14.1	29.8	74.9	74.8	75.6	0.8	end	
6	314.9	LOGPER	V	-18.1	-18.2	14.1	29.8	73.2	73.1	75.6	2.5	side	
7	Chrome Si	des w/o Imm	ob Key	Cover									
8	314.9	LOGPER	Н	-17.3	-17.4	14.1	29.8	74.0	73.9	75.6	1.7	end	
9	314.9	LOGPER	V	-19.4	-19.5	14.1	29.8	71.9	71.8	75.6	3.8	side	
10													
11													
12													
13													
14													
15													
	Freq.	D	C Supp	ly	Relative F								
#	MHz		Voltage			dBm**							
7	314.9	2.60			-17.0								
8	314.9		2.80			-16.8							
9	314.9		3.00			-16.4							
10	314.9		3.15			3							
11	314.9	1	3.30			4							
	Avg data computed from Pack Massured Data and EUT Duty Cycle. EUT in CW mode												

*Avg data computed from Peak Measured Data and EUT Duty Cycle. EUT in CW mode.

** EUT in CW mode.

Equipment Used: DIPEMC001, RSFSV30001

3.2.4Exposure and Potential Health Hazard

To demonstrate compliance with with regulations that place limitations on human electromagnetic field exposure for both the general public and for workers, we compute EIRP from measured emission data. These levels are compared with limits placed by the directives and recommendations detailed in Section 1.1. Table 7 details the results of these computations.

 Table 7: Electromagnetic Field Exposure.

USA REF: IC REF: Min. Sep. Distance:	Test Date: Test Engineer: EUT: EUT Mode: Meas. Distance:	Joseph Brunett Strattec AM Series CW			
Freq.	E3(Pk)*	Duty Factor	E3(Avg)**	EIRP(Avg)**	EIRP(Avg)**
MHz	dBµV/m	dB	dBuV/m	dBm	mW
314.90	74.9	.0	74.9	-20.3	.0093998
	Canada			USA	
Calculated SAR Threshold (Avg) mW	1-g SAR Body Power Threshold Exclusion Limit (Avg) mW	10-g SAR Extremity Power Threshold Exclusion Limit (Avg) mW	Calculated SAR Threshold (Avg)	1-g SAR Body Power Threshold Exclusion Limit (Avg)	10-g SAR Extremity Power Threshold Exclusion Limit (Avg)
.0093998	69.1	172.8	.0010550	3.0	7.5

*As Measured / Computed from highest fundamental emission, see fundamental emission section of this report.

**Only RMS level is required, RMS/6min << Pk, Peak emission employed to demonstrate compliance.

3.3 Unintentional Emissions

3.3.1 Transmit Chain Spurious Emissions

Test Setup & Procedure The test equipment and facilities were setup in accordance with the standards and procedures listed in Section 1.1. Environmental conditions were set at the appropriate temperature and thermal balance was checked with a thermocouple based probe. Spurious radiated emissions measurements are performed to 10 times the highest fundamental operating frequency. The test equipment employed includes RSFSV30001, DIPEMC001, HRNQR316401.

Measurement Results The details and results of testing the EUT are summarized in Table 8.

Frequency Range			Frequency Range Det 5 MHz f 1 000 MHz Pk/QPk						andwidth kHz		Test Date: Engineer:	8
$f > 1\ 000\ MHz$						120 kHz 1 MHz			1Hz	rest	EUT	
	$f > 1\ 000\ MHz$			Avg			1Hz	10kHz		FI	JT Mode:	
	1 > 1 000 1	VIIIZ		Avg		1 1	1112	TUKHZ			Meas. Distance:	
										wicas.	Distance	3 meters
					smitter Unin	tentiona	l Spurio					FCC/IC
	Freq.	Ant.	Ant.	Pr (Pk)	Pr (Avg)*	Ka	Kg	E3(Pk)	E3(Avg)	FCC/IC E3lim (Avg)	Pass	
#	MHz	Used	Pol.	dBm	dBm	dB/m	dB	$dB\mu V\!/\!m$	$dB\mu V\!/\!m$	dBµV/m	dB	Comments
1	Plastic Side	s										
2	629.8	LOGPER	Н	-71.1	-71.2	19.5	31.2	24.1	24.0	55.7	31.6	max all
3	629.8	LOGPER	V	-70.7	-70.8	19.5	31.2	24.5	24.4	55.7	31.2	max all
4	944.7	LOGPER	Н	-70.3	-70.4	23.1	28.3	31.6	31.5	55.7	24.2	max all
5	944.7	LOGPER	Н	-68.4	-68.5	23.1	28.3	33.5	33.4	55.7	22.3	max all
6	1259.6	R-Horn	H/V	-101.3	-101.4	25.0	0.0	30.7	30.6	54.0	23.4	max all
7	1574.5	R-Horn	H/V	-100.4	-100.5	27.6	0.0	34.2	34.1	54.0	19.9	max all
8	1889.4	R-Horn	H/V	-91.5	-91.6	29.4	0.0	44.9	44.8	55.7	10.9	max all
9	2204.3	R-Horn	H/V	-96.4	-96.5	30.9	0.0	41.5	41.4	54.0	12.6	max all
10	2519.2	R-Horn	H/V	-100.1	-100.2	33.1	0.0	40.0	39.9	55.7	15.7	max all
11	2834.1	R-Horn	H/V	-96.1	-96.2	35.6	0.0	46.5	46.4	54.0	7.6	max all
12	3149.0	R-Horn	H/V	-95.7	-95.8	36.7	0.0	48.0	47.9	55.7	7.8	max all
13	Chrome Sid	les										
14	629.8	Dip	Н	-66.5	-70.2	24.4	31.2	33.6	29.9	55.7	25.7	max all
15	629.8	Dip	V	-68.1	-69.8	24.4	31.2	32.0	30.3	55.7	25.3	max all
16	944.7	Dip	Н	-70.7	-69.2	28.8	28.3	36.9	38.4	55.7	18.8	max all
17	944.7	Dip	Н	-82.0	-67.3	28.8	28.3	25.6	40.3	55.7	30.1	max all
18	1259.6	R-Horn	H/V	-101.2	-101.3	25.0	0.0	30.8	30.7	54.0	23.3	max all
19	1574.5	R-Horn	H/V	-101.8	-101.9	27.6	0.0	32.9	32.8	54.0	21.2	max all
20	1889.4	R-Horn	H/V	-100.1	-100.2	29.4	0.0	36.3	36.2	55.7	19.5	max all
21	2204.3	R-Horn	H/V	-97.0	-97.1	30.9	0.0	40.9	40.8	54.0	13.2	max all
22	2519.2	R-Horn	H/V	-101.5	-101.6	33.1	0.0	38.6	38.5	55.7	17.1	max all
23	2834.1	R-Horn	H/V	-100.6	-100.7	35.6	0.0	42.0	41.9	54.0	12.1	max all
24	3149.0	R-Horn	H/V	-94.4	-94.5	36.7	0.0	49.3	49.2	55.7	6.5	max all
25												
26												

Table 8: Transmit Chain Spurious Emissions.

*Avg data computed from Peak Measured Data and EUT Duty Cycle. EUT in CW mode. Equipment Used: DIPEMC001, UMHORN005, RSFSV30001

3.3.2 Radiated Digital Spurious

The results for the measurement of digital spurious emissions are not reported herein as all digital emissions were greater than 20 dB below the regulatory limit. Radiation from digital components was measured to 4 GHz, or to five times the maximum digital component operating frequency, whichever is greater.

4 Measurement Uncertainty

The maximum values of measurement uncertainty for the laboratory test equipment and facilities associated with each test are given in the table below. This uncertainty is computed for a 95.45% confidence level based on a coverage factor of k = 2.

Table 9: Measurement Uncertainty.

Measured Parameter	${\bf Measurement} ~ {\bf Uncertainty}^{\dagger}$
Radio Frequency	$\pm (f_{Mkr}/10^7 + RBW/10 + (SPN/(PTS - 1))/2 + 1 \text{ Hz})$
Conducted Emm. Amplitude	$\pm 1.8\mathrm{dB}$
Radiated Emm. Amplitude $(30 - 200 \text{ MHz})$	$\pm 2.7\mathrm{dB}$
Radiated Emm. Amplitude $(200 - 1000 \text{ MHz})$	$\pm 2.5\mathrm{dB}$
Radiated Emm. Amplitude $(f > 1000 \text{ MHz})$	$\pm 3.7\mathrm{dB}$
DC and Low Frequency Voltages	$\pm 2\%$
Temperature	$\pm 0.5^{\circ}\mathrm{C}$
Humidity	$\pm 5\%$

[†]Ref: CISPR 16-4-2:2011+A1:2014